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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details

Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	800MHz
Co-Processors/DSP	Signal Processing; SPE
RAM Controllers	DDR, DDR2, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	-
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCBGA (29x29)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mpc8543vuang

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

NOTE

From a system standpoint, if any of the I/O power supplies ramp prior to the V_{DD} core supply, the I/Os associated with that I/O supply may drive a logic one or zero during power-up, and extra current may be drawn by the device.

Table 13 provides the recommended operating conditions for the DDR SDRAM controller when $GV_{DD}(typ) = 2.5 \text{ V}.$

Parameter/Condition	Symbol	Min	Max	Unit	Notes
I/O supply voltage	GV _{DD}	2.375	2.625	V	1
I/O reference voltage	MV _{REF}	$0.49 \times GV_{DD}$	$0.51 imes GV_{DD}$	V	2
I/O termination voltage	V _{TT}	MV _{REF} – 0.04	MV _{REF} + 0.04	V	3
Input high voltage	V _{IH}	MV _{REF} + 0.15	GV _{DD} + 0.3	V	—
Input low voltage	V _{IL}	-0.3	MV _{REF} – 0.15	V	—
Output leakage current	I _{OZ}	-50	50	μΑ	4
Output high current (V _{OUT} = 1.95 V)	I _{OH}	-16.2	—	mA	—
Output low current (V _{OUT} = 0.35 V)	I _{OL}	16.2	—	mA	—

Table 13. DDR SDRAM DC Electrical	Characteristics for $GV_{DD}(typ) = 2.5 V$

Notes:

1. ${\rm GV}_{\rm DD}$ is expected to be within 50 mV of the DRAM ${\rm V}_{\rm DD}$ at all times.

2. MV_{REF} is expected to be equal to 0.5 × GV_{DD}, and to track GV_{DD} DC variations as measured at the receiver. Peak-to-peak noise on MV_{REF} may not exceed ±2% of the DC value.

3. V_{TT} is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MV_{REF}. This rail must track variations in the DC level of MV_{REF}.

4. Output leakage is measured with all outputs disabled, 0 V \leq V_{OUT} \leq GV_{DD}.

Table 14 provides the DDR I/O capacitance when $GV_{DD}(typ) = 2.5$ V.

Table 14. DDR SDRAM Capacitance for GV_{DD}(typ) = 2.5 V

Parameter/Condition	Symbol	Min	Max	Unit	Notes
Input/output capacitance: DQ, DQS	C _{IO}	6	8	pF	1
Delta input/output capacitance: DQ, DQS	C _{DIO}		0.5	pF	1

Note:

1. This parameter is sampled. $GV_{DD} = 2.5 \text{ V} \pm 0.125 \text{ V}$, f = 1 MHz, T_A = 25°C, $V_{OUT} = GV_{DD}/2$, V_{OUT} (peak-to-peak) = 0.2 V.

This table provides the current draw characteristics for MV_{REF}.

Table 15. Current Draw Characteristics for MV_{REF}

Parameter/Condition	Symbol	Min	Max	Unit	Notes
Current draw for MV _{REF}	I _{MVREF}		500	μA	1

Note:

1. The voltage regulator for MV_{REF} must be able to supply up to 500 μ A current.

Ethernet Management Interface Electrical Characteristics

Table 37. MII Management AC Timing Specifications (continued)

At recommended operating conditions with OV_{DD} is 3.3 V ± 5%.

Parameter	Symbol ¹	Min	Тур	Мах	Unit	Notes
MDC fall time	t _{MDHF}			10	ns	4

Notes:

- The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t_{(first two letters of functional block)(reference)(state)(signal)(state)} for outputs. For example, t_{MDKHDX} symbolizes management data timing (MD) for the time t_{MDC} from clock reference (K) high (H) until data outputs (D) are invalid (X) or data hold time. Also, t_{MDDVKH} symbolizes management data timing (MD) with respect to the time data input signals (D) reach the valid state (V) relative to the t_{MDC} clock reference (K) going to the high (H) state or setup time. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).
 </sub>
- 2. This parameter is dependent on the eTSEC system clock speed, which is half of the Platform Frequency (f_{CCB}). The actual ECn_MDC output clock frequency for a specific eTSEC port can be programmed by configuring the MgmtClk bit field of device's MIIMCFG register, based on the platform (CCB) clock running for the device. The formula is: Platform Frequency (CCB) ÷ (2 × Frequency Divider determined by MIICFG[MgmtClk] encoding selection). For example, if MIICFG[MgmtClk] = 000 and the platform (CCB) is currently running at 533 MHz, f_{MDC} = 533) ÷ (2 × 4 × 8) = 533) ÷ 64 = 8.3 MHz. That is, for a system running at a particular platform frequency (f_{CCB}), the ECn_MDC output clock frequency can be programmed between maximum f_{MDC} = f_{CCB} ÷ 64 and minimum f_{MDC} = f_{CCB} ÷ 448. See 14.5.3.6.6, "MII Management Configuration Register (MIIMCFG)," in the MPC8548E PowerQUICC™ III Integrated Processor Family Reference Manual for more detail.
- 3. The maximum ECn_MDC output clock frequency is defined based on the maximum platform frequency for device (533 MHz) divided by 64, while the minimum ECn_MDC output clock frequency is defined based on the minimum platform frequency for device (333 MHz) divided by 448, following the formula described in Note 2 above.
- 4. Guaranteed by design.
- 5. t_{CCB} is the platform (CCB) clock period.

Figure 21 shows the MII management AC timing diagram.

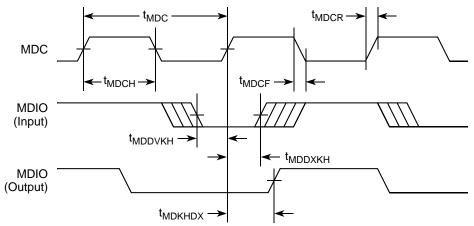


Figure 21. MII Management Interface Timing Diagram

10 Local Bus

This section describes the DC and AC electrical specifications for the local bus interface of the device.

10.1 Local Bus DC Electrical Characteristics

This table provides the DC electrical characteristics for the local bus interface operating at $BV_{DD} = 3.3 \text{ V DC}$.

Parameter	Symbol	Min	Мах	Unit
High-level input voltage	V _{IH}	2	BV _{DD} + 0.3	V
Low-level input voltage	V _{IL}	-0.3	0.8	V
Input current $(V_{IN}^{1} = 0 V \text{ or } V_{IN} = BV_{DD})$	I _{IN}	_	±5	μA
High-level output voltage ($BV_{DD} = min, I_{OH} = -2 mA$)	V _{OH}	2.4	—	V
Low-level output voltage ($BV_{DD} = min$, $I_{OL} = 2 mA$)	V _{OL}	—	0.4	V

Table 38. Local Bus DC Electrical Characteristics (3.3 V DC)

Note:

1. Note that the symbol V_{IN} , in this case, represents the BV_{IN} symbol referenced in Table 1 and Table 2.

Table 39 provides the DC electrical characteristics for the local bus interface operating at $BV_{DD} = 2.5 \text{ V DC}$.

Table 39. Local Bus DC Electrical Characteristics (2.5 V DC)

Parameter	Symbol	Min	Max	Unit
High-level input voltage	V _{IH}	1.70	BV _{DD} + 0.3	V
Low-level input voltage	V _{IL}	-0.3	0.7	V
Input current $(V_{IN}^{1} = 0 V \text{ or } V_{IN} = BV_{DD})$	I _{IH}	_	10	μA
	I		-15	
High-level output voltage ($BV_{DD} = min, I_{OH} = -1 mA$)	V _{OH}	2.0	—	V
Low-level output voltage ($BV_{DD} = min$, $I_{OL} = 1 mA$)	V _{OL}	_	0.4	V

Note:

1. Note that the symbol V_{IN} , in this case, represents the BV_{IN} symbol referenced in Table 1 and Table 2.

10.2 Local Bus AC Electrical Specifications

This table describes the timing parameters of the local bus interface at $BV_{DD} = 3.3$ V. For information about the frequency range of local bus, see Section 20.1, "Clock Ranges."

Parameter	Symbol ¹	Min	Max	Unit	Notes
Local bus cycle time	t _{LBK}	7.5	12	ns	2
Local bus duty cycle	t _{LBKH/} t _{LBK}	43	57	%	—
LCLK[n] skew to LCLK[m] or LSYNC_OUT	t _{LBKSKEW}	_	150	ps	7, 8
Input setup to local bus clock (except LGTA/LUPWAIT)	t _{LBIVKH1}	1.8		ns	3, 4
LGTA/LUPWAIT input setup to local bus clock	t _{LBIVKH2}	1.7	_	ns	3, 4
Input hold from local bus clock (except LGTA/LUPWAIT)	t _{LBIXKH1}	1.0	_	ns	3, 4
LGTA/LUPWAIT input hold from local bus clock	t _{LBIXKH2}	1.0		ns	3, 4
LALE output transition to LAD/LDP output transition (LATCH hold time)	t _{LBOTOT}	1.5	_	ns	6
Local bus clock to output valid (except LAD/LDP and LALE)	t _{LBKHOV1}	_	2.0	ns	—
Local bus clock to data valid for LAD/LDP	t _{LBKHOV2}	_	2.2	ns	3
Local bus clock to address valid for LAD	t _{LBKHOV3}	_	2.3	ns	3
Local bus clock to LALE assertion	t _{LBKHOV4}	_	2.3	ns	3
Output hold from local bus clock (except LAD/LDP and LALE)	t _{LBKHOX1}	0.7	_	ns	3
Output hold from local bus clock for LAD/LDP	t _{LBKHOX2}	0.7	_	ns	3
Local bus clock to output high Impedance (except LAD/LDP and LALE)	t _{LBKHOZ1}		2.5	ns	5
Local bus clock to output high impedance for LAD/LDP	t _{LBKHOZ2}	_	2.5	ns	5

Table 40. Local Bus Timing Parameters (BV_{DD} = 3.3 V)—PLL Enabled

Notes:

- The symbols used for timing specifications follow the pattern of t<sub>(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t_{(first two letters of functional block)(reference)(state)(signal)(state)} for outputs. For example, t_{LBIXKH1} symbolizes local bus timing (LB) for the input (I) to go invalid (X) with respect to the time the t_{LBK} clock reference (K) goes high (H), in this case for clock one (1). Also, t_{LBKH0X} symbolizes local bus timing (LB) for the t_{LBK} clock reference (K) to go high (H), with respect to the output (O) going invalid (X) or output hold time.
 </sub>
- 2. All timings are in reference to LSYNC_IN for PLL enabled and internal local bus clock for PLL bypass mode.
- 3. All signals are measured from $BV_{DD}/2$ of the rising edge of LSYNC_IN for PLL enabled or internal local bus clock for PLL bypass mode to $0.4 \times BV_{DD}$ of the signal in question for 3.3-V signaling levels.
- 4. Input timings are measured at the pin.
- 5. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- 6. t_{LBOTOT} is a measurement of the minimum time between the negation of LALE and any change in LAD. t_{LBOTOT} is programmed with the LBCR[AHD] parameter.
- 7. Maximum possible clock skew between a clock LCLK[m] and a relative clock LCLK[n]. Skew measured between complementary signals at BV_{DD}/2.
- 8. Guaranteed by design.

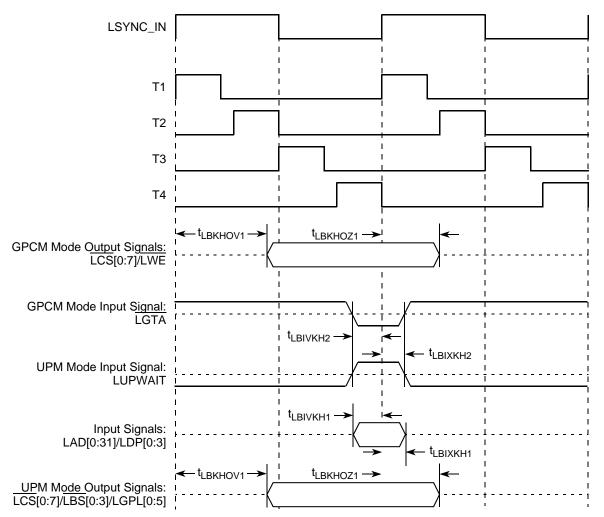


Figure 27. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 8 or 16 (PLL Enabled)

Parameter	Symbol ²	Min	Мах	Unit	Notes
Valid times: Boundary-scan data TDO	t _{jtkldv} t _{jtklov}	4 2	20 10	ns	5
Output hold times: Boundary-scan data TDO	t _{jtkldx} t _{jtklox}	30 30		ns	5
JTAG external clock to output high impedance: Boundary-scan data TDO	t _{jtkldz} t _{jtkloz}	3 3	19 9	ns	5, 6

 Table 44. JTAG AC Timing Specifications (Independent of SYSCLK)¹ (continued)

Notes:

- All outputs are measured from the midpoint voltage of the falling/rising edge of t_{TCLK} to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load (see Figure 29). Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.
- 2. The symbols used for timing specifications follow the pattern of t_{(first two letters of functional block)(signal)(state)(reference)(state) for inputs and t_{(first two letters of functional block)(reference)(state)(signal)(state)} for outputs. For example, t_{JTDVKH} symbolizes JTAG device timing (JT) with respect to the time data input signals (D) reaching the valid state (V) relative to the t_{JTG} clock reference (K) going to the high (H) state or setup time. Also, t_{JTDXKH} symbolizes JTAG timing (JT) with respect to the time data input signals (D) went invalid (X) relative to the t_{JTG} clock reference (K) going to the high (H) state. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).}
- 3. TRST is an asynchronous level sensitive signal. The setup time is for test purposes only.
- 4. Non-JTAG signal input timing with respect to t_{TCLK}.
- 5. Non-JTAG signal output timing with respect to t_{TCLK}.
- 6. Guaranteed by design.

Figure 29 provides the AC test load for TDO and the boundary-scan outputs.

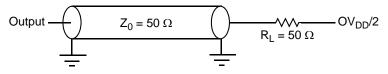


Figure 29. AC Test Load for the JTAG Interface

Figure 30 provides the JTAG clock input timing diagram.

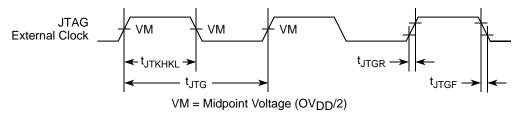


Figure 30. JTAG Clock Input Timing Diagram

14 GP_{OUT}/GP_{IN}

This section describes the DC and AC electrical specifications for the GP_{OUT}/GP_{IN} bus of the device.

14.1 GP_{OUT}/GP_{IN} Electrical Characteristics

Table 47 and Table 48 provide the DC electrical characteristics for the GP_{OUT} interface.

Parameter	Symbol	Min	Мах	Unit
Supply voltage 3.3 V	BV _{DD}	3.13	3.47	V
High-level output voltage (BV _{DD} = min, I _{OH} = -2 mA)	V _{OH}	BV _{DD} – 0.2	_	V
Low-level output voltage (BV _{DD} = min, I _{OL} = 2 mA)	V _{OL}	—	0.2	V

 Table 47. GP_{OUT} DC Electrical Characteristics (3.3 V DC)

 Table 48. GP_{OUT} DC Electrical Characteristics (2.5 V DC)

Parameter	Symbol	Min	Мах	Unit
Supply voltage 2.5 V	BV _{DD}	2.37	2.63	V
High-level output voltage ($BV_{DD} = min, I_{OH} = -1 mA$)	V _{OH}	2.0	BV _{DD} + 0.3	V
Low-level output voltage (BV _{DD} min, I _{OL} = 1 mA)	V _{OL}	GND – 0.3	0.4	V

Table 49 and Table 50 provide the DC electrical characteristics for the GP_{IN} interface.

Table 49. GP_{IN} DC Electrical Characteristics (3.3 V DC)

Parameter	Symbol	Min	Мах	Unit
Supply voltage 3.3 V	BV _{DD}	3.13	3.47	V
High-level input voltage	V _{IH}	2	BV _{DD} + 0.3	V
Low-level input voltage	V _{IL}	-0.3	0.8	V
Input current (BV _{IN} ¹ = 0 V or BV _{IN} = BV _{DD})	I _{IN}	_	±5	μA

Note:

1. The symbol $\mathsf{BV}_{\mathsf{IN}}$, in this case, represents the $\mathsf{BV}_{\mathsf{IN}}$ symbol referenced in Table 1.

Table 53. PCI-X AC Timing Specifications at 66 MHz (continued)

Parameter	Symbol	Min	Max	Unit	Notes
HRESET to PCI-X initialization pattern hold time	t _{PCRHIX}	0	50	ns	6, 11

Notes:

- 1. See the timing measurement conditions in the PCI-X 1.0a Specification.
- 2. Minimum times are measured at the package pin (not the test point). Maximum times are measured with the test point and load circuit.
- 3. Setup time for point-to-point signals applies to REQ and GNT only. All other signals are bused.
- 4. For purposes of active/float timing measurements, the Hi-Z or off state is defined to be when the total current delivered through the component pin is less than or equal to the leakage current specification.
- 5. Setup time applies only when the device is not driving the pin. Devices cannot drive and receive signals at the same time.
- 6. Maximum value is also limited by delay to the first transaction (time for HRESET high to first configuration access, t_{PCRHFV}). The PCI-X initialization pattern control signals after the rising edge of HRESET must be negated no later than two clocks before the first FRAME and must be floated no later than one clock before FRAME is asserted.
- 7. A PCI-X device is permitted to have the minimum values shown for t_{PCKHOV} and t_{CYC} only in PCI-X mode. In conventional mode, the device must meet the requirements specified in PCI 2.2 for the appropriate clock frequency.
- 8. Device must meet this specification independent of how many outputs switch simultaneously.

9. The timing parameter t_{PCRHFV} is a minimum of 10 clocks rather than the minimum of 5 clocks in the PCI-X 1.0a Specification.

10.Guaranteed by characterization.

11.Guaranteed by design.

This table provides the PCI-X AC timing specifications at 133 MHz. Note that the maximum PCI-X frequency in synchronous mode is 110 MHz.

Parameter	Symbol	Min	Max	Unit	Notes
SYSCLK to signal valid delay	^t PCKHOV	_	3.8	ns	1, 2, 3, 7, 8
Output hold from SYSCLK	t _{PCKHOX}	0.7	_	ns	1, 11
SYSCLK to output high impedance	t _{PCKHOZ}		7	ns	1, 4, 8, 12
Input setup time to SYSCLK	t _{PCIVKH}	1.2	_	ns	3, 5, 9, 11
Input hold time from SYSCLK	t _{PCIXKH}	0.5	-	ns	11
REQ64 to HRESET setup time	t _{PCRVRH}	10	_	clocks	12
HRESET to REQ64 hold time	t _{PCRHRX}	0	50	ns	12
HRESET high to first FRAME assertion	t _{PCRHFV}	10	_	clocks	10, 12
PCI-X initialization pattern to HRESET setup time	^t PCIVRH	10		clocks	12

Table 54. PCI-X AC Timing Specifications at 133 MHz

Serial RapidIO

Characteristic	Symbol	Range		Unit	Notes	
Characteristic	Symbol	Min	Max	Onit	NOICES	
Output voltage	V _O	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair	
Differential output voltage	V _{DIFFPP}	800	1600	mVp-p	—	
Deterministic jitter	J _D	—	0.17	UI p-p	—	
Total jitter	J _T	—	0.35	UI p-p	—	
Multiple output skew	S _{MO}	—	1000	ps	Skew at the transmitter output between lanes of a multilane link	
Unit interval	UI	400	400	ps	±100 ppm	

Table 64. Long Run Transmitter AC Timing Specifications—3.125 GBaud

Characteristic	Symbol	Ra	nge	Unit	Notes
Characteristic	Symbol	Min	Max	Onic	NULES
Output voltage	V _O	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair
Differential output voltage	V _{DIFFPP}	800	1600	mVp-p	—
Deterministic jitter	J _D	—	0.17	UI p-p	—
Total jitter	J _T	—	0.35	UI p-p	—
Multiple output skew	S _{MO}	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit interval	UI	320	320	ps	±100 ppm

For each baud rate at which an LP-serial transmitter is specified to operate, the output eye pattern of the transmitter shall fall entirely within the unshaded portion of the transmitter output compliance mask shown in Figure 52 with the parameters specified in Table 65 when measured at the output pins of the device and the device is driving a $100-\Omega \pm 5\%$ differential resistive load. The output eye pattern of an LP-serial

Characteristic	Symbol	Range		Unit	Notes
Characteristic	Symbol	Min	Max	Onit	NOICES
Differential input voltage	V _{IN}	200	1600	mVp-p	Measured at receiver
Deterministic jitter tolerance	J _D	0.37	—	UI p-p	Measured at receiver
Combined deterministic and random jitter tolerance	J _{DR}	0.55	—	UI p-p	Measured at receiver
Total jitter tolerance ¹	J _T	0.65	_	UI p-p	Measured at receiver
Multiple input skew	S _{MI}	_	22	ns	Skew at the receiver input between lanes of a multilane link
Bit error rate	BER	_	10 ⁻¹²		—
Unit interval	UI	320	320	ps	±100 ppm

Table 68. Receiver	AC Timing	Specifications-	-3.125 GBaud
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Note:

1. Total jitter is composed of three components, deterministic jitter, random jitter and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 53. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.

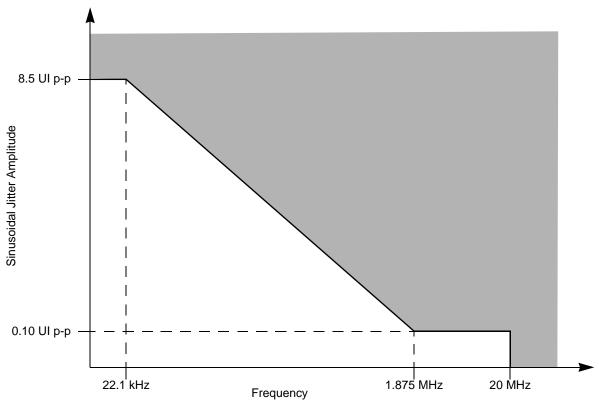


Figure 53. Single Frequency Sinusoidal Jitter Limits

Notes:

- 1. All dimensions are in millimeters.
- 2. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 3. Maximum solder ball diameter measured parallel to datum A.
- 4. Datum A, the seating plane, is determined by the spherical crowns of the solder balls.
- 5. Parallelism measurement shall exclude any effect of mark on top surface of package.
- 6. All dimensions are symmetric across the package center lines unless dimensioned otherwise.

19.3 Pinout Listings

NOTE

The DMA_DACK[0:1] and TEST_SEL/TEST_SEL pins must be set to a proper state during POR configuration. See the pinlist table of the individual device for more details.

For MPC8548/47/45, GPIOs are still available on PCI1_AD[63:32]/PC2_AD[31:0] pins if they are not used for PCI functionality.

For MPC8545/43, eTSEC does not support 16 bit FIFO mode.

Table 71 provides the pinout listing for the MPC8548E 783 FC-PBGA package.

Signal	Package Pin Number	Pin Type	Power Supply	Notes		
PCI1 and PCI2 (One 64-Bit or Two 32-Bit)						
PCI1_AD[63:32]/PCI2_AD[31:0]	AB14, AC15, AA15, Y16, W16, AB16, AC16, AA16, AE17, AA18, W18, AC17, AD16, AE16, Y17, AC18, AB18, AA19, AB19, AB21, AA20, AC20, AB20, AB22, AC22, AD21, AB23, AF23, AD23, AE23, AC23, AC24	I/O	OV _{DD}	17		
PCI1_AD[31:0]	AH6, AE7, AF7, AG7, AH7, AF8, AH8, AE9, AH9, AC10, AB10, AD10, AG10, AA10, AH10, AA11, AB12, AE12, AG12, AH12, AB13, AA12, AC13, AE13, Y14, W13, AG13, V14, AH13, AC14, Y15, AB15	I/O	OV _{DD}	17		
PCI1_C_BE[7:4]/PCI2_C_BE[3:0]	AF15, AD14, AE15, AD15	I/O	OV _{DD}	17		
PCI1_C_BE[3:0]	AF9, AD11, Y12, Y13	I/O	OV _{DD}	17		
PCI1_PAR64/PCI2_PAR	W15	I/O	OV _{DD}			
PCI1_GNT[4:1]	AG6, AE6, AF5, AH5	0	OV _{DD}	5, 9, 35		
PCI1_GNT0	AG5	I/O	OV _{DD}	—		
PCI1_IRDY	AF11	I/O	OV _{DD}	2		
PCI1_PAR	AD12	I/O	OV _{DD}	—		
PCI1_PERR	AC12	I/O	OV _{DD}	2		
PCI1_SERR	V13	I/O	OV _{DD}	2, 4		
PCI1_STOP	W12	I/O	OV _{DD}	2		
PCI1_TRDY	AG11	I/O	OV _{DD}	2		

Table 71. MPC8548E Pinout Listing

Table 71. MPC8548E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
25.These are test signals for factory u	ise only and must be pulled up (100 Ω –1 k Ω) to	OV _{DD} for normal	machine oper	ration.
26.Independent supplies derived from	n board V _{DD} .			
27.Recommend a pull-up resistor (~1	$k\Omega$) be placed on this pin to OV_{DD} .			
	oul <u>led down du</u> ring power-on reset: TSEC3_TXD Y/QUIESCE, MSRCID[2:4], ASLEEP.	[3], TSEC4_TXD	93/TSEC3_TX	D7,
30.This pin requires an external 4.7-ks driven.	2 pull-down resistor to prevent PHY from seeing a	valid transmit en	able before it i	s active
31.This pin is only an output in eTSE	C3 FIFO mode when used as Rx flow control.			
32. These pins must be connected to 2	XV _{DD} .			
33. <u>TSEC2_</u> TXD1, TSEC2_TX_ER ar HRESET assertion.	e multiplexed as cfg_dram_type[0:1]. They must	be valid at powe	er-up, even bet	fore
34.These pins must be pulled to grou	nd through a 300- Ω (±10%) resistor.			
down to select external arbiter if the connect' or terminated through 2–1 connected to any other PCI device.	er the POR config pin that selects between inter ere is any other PCI device connected on the PC 0 k Ω pull-up resistors with the default of internal . The PCI block drives the PCI <i>n</i> _AD pins if it is con- thether it is disabled via the DEVDISR register of the bus.	l bus, or leave th arbiter if the PC onfigured to be th	e PCI <i>n_</i> AD pi n_AD pins are e PCI arbiter–	ns as 'n e not –throug
	$2-\Omega$ precision 1% resistor and MDIC1 is connector automatic calibration of the DDR IOs.	ed to GV _{DD} throu	gh an 18.2-Ω	precisio
38.These pins must be left floating.				
39. If PCI1 or PCI2 is configured as P Otherwise the processor will not be	CI asynchronous mode, a valid clock must be pr oot up.	ovided on pin PC	CI1_CLK or PC	CI2_CL
40.These pins must be connected to	GND.			
101.This pin requires an external 4.7-	$k\Omega$ resistor to GND.			
102.For Rev. 2.x silicon, DMA_DACK POR configuration are don't care.	[0:1] must be 0b11 during POR configuration; for	r rev. 1.x silicon, t	the pin values	during
103.If these pins are not used as GPI 2–10 kΩ resistors.	Nn (general-purpose input), they must be pulled	low (to GND) or	high (to LV _{DD})) throug
104.These must be pulled low to GNI	D through 2–10 k Ω resistors if they are not used.			
	to LV_{DD} through 2–10 k Ω resistors if they are no			
106.For rev. 2.x silicon, DMA_DACK[(configuration are don't care.):1] must be 0b10 during POR configuration; for re	ev. 1.x silicon, the	pin values du	ring PO
107.For rev. 2.x silicon, DMA_DACK[0 configuration are don't care.):1] must be 0b01 during POR configuration; for re	ev. 1.x silicon, the	pin values du	ring PO
108.For rev. 2.x silicon, DMA_DACK[C configuration are don't care.	0:1] must be 0b11 during POR configuration; for re	ev. 1.x silicon, the	pin values du	ring PO
109.This is a test signal for factory us	e only and must be pulled down (100 Ω – 1 k Ω)	to GND for norm	al machine op	eration.
110.These pins must be pulled high to	o OV _{DD} through 2–10 k Ω resistors.			
111.If these pins are not used as GPII 2–10 k Ω resistors.	Nn (general-purpose input), they must be pulled	low (to GND) or I	high (to OV _{DD})) throug
112.This pin must not be pulled down	during POR configuration.			

Table 72 provides the pin-out listing for the MPC8547E 783 FC-PBGA package.

NOTE

All note references in the following table use the same numbers as those for Table 71. See Table 71 for the meanings of these notes.

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	PCI1 (One 64-Bit or One 32-Bit)		1	
PCI1_AD[63:32]	AB14, AC15, AA15, Y16, W16, AB16, AC16, AA16, AE17, AA18, W18, AC17, AD16, AE16, Y17, AC18, AB18, AA19, AB19, AB21, AA20, AC20, AB20, AB22, AC22, AD21, AB23, AF23, AD23, AE23, AC23, AC24	I/O	OV _{DD}	17
PCI1_AD[31:0]	AH6, AE7, AF7, AG7, AH7, AF8, AH8, AE9, AH9, AC10, AB10, AD10, AG10, AA10, AH10, AA11, AB12, AE12, AG12, AH12, AB13, AA12, AC13, AE13, Y14, W13, AG13, V14, AH13, AC14, Y15, AB15	I/O	OV _{DD}	17
PCI1_C_BE[7:4]	AF15, AD14, AE15, AD15	I/O	OV _{DD}	17
PCI1_C_BE[3:0]	AF9, AD11, Y12, Y13	I/O	OV _{DD}	17
PCI1_PAR64	W15	I/O	OV _{DD}	—
PCI1_GNT[4:1]	AG6, AE6, AF5, AH5	0	OV _{DD}	5, 9, 35
PCI1_GNT0	AG5	I/O	OV _{DD}	—
PCI1_IRDY	AF11	I/O	OV _{DD}	2
PCI1_PAR	AD12	I/O	OV _{DD}	—
PCI1_PERR	AC12	I/O	OV _{DD}	2
PCI1_SERR	V13	I/O	OV _{DD}	2, 4
PCI1_STOP	W12	I/O	OV _{DD}	2
PCI1_TRDY	AG11	I/O	OV _{DD}	2
PCI1_REQ[4:1]	AH2, AG4, AG3, AH4	I	OV _{DD}	—
PCI1_REQ0	AH3	I/O	OV _{DD}	—
PCI1_CLK	AH26	I	OV _{DD}	39
PCI1_DEVSEL	AH11	I/O	OV _{DD}	2
PCI1_FRAME	AE11	I/O	OV _{DD}	2
PCI1_IDSEL	AG9	I	OV _{DD}	—
PCI1_REQ64	AF14	I/O	OV _{DD}	2, 5,10
PCI1_ACK64	V15	I/O	OV _{DD}	2
Reserved	AE28	—	—	2
Reserved	AD26	_	—	2
Reserved	AD25	—	—	2

Table 72. MPC8547E Pinout Listing

Table 72	. MPC8547E	Pinout Listing	(continued)
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Signal	Package Pin Number	Pin Type	Power Supply	Notes
Reserved	AE26	_	—	2
cfg_pci1_clk	AG24	I	OV _{DD}	5
Reserved	AF25	_	—	101
Reserved	AE25	_	—	2
Reserved	AG25	_	—	2
Reserved	AD24	_	—	2
Reserved	AF24	_	—	2
Reserved	AD27	_	—	2
Reserved	AD28, AE27, W17, AF26	_	—	2
Reserved	AH25	_	—	2
	DDR SDRAM Memory Interface			1
MDQ[0:63]	L18, J18, K14, L13, L19, M18, L15, L14, A17, B17, A13, B12, C18, B18, B13, A12, H18, F18, J14, F15, K19, J19, H16, K15, D17, G16, K13, D14, D18, F17, F14, E14, A7, A6, D5, A4, C8, D7, B5, B4, A2, B1, D1, E4, A3, B2, D2, E3, F3, G4, J5, K5, F6, G5, J6, K4, J1, K2, M5, M3, J3, J2, L1, M6	I/O	GV _{DD}	_
MECC[0:7]	H13, F13, F11, C11, J13, G13, D12, M12	I/O	GV _{DD}	—
MDM[0:8]	M17, C16, K17, E16, B6, C4, H4, K1, E13	0	GV _{DD}	—
MDQS[0:8]	M15, A16, G17, G14, A5, D3, H1, L2, C13	I/O	GV _{DD}	—
MDQS[0:8]	L17, B16, J16, H14, C6, C2, H3, L4, D13	I/O	GV _{DD}	—
MA[0:15]	A8, F9, D9, B9, A9, L10, M10, H10, K10, G10, B8, E10, B10, G6, A10, L11	0	GV _{DD}	_
MBA[0:2]	F7, J7, M11	0	GV _{DD}	—
MWE	E7	0	GV _{DD}	—
MCAS	H7	0	GV _{DD}	—
MRAS	L8	0	GV _{DD}	—
MCKE[0:3]	F10, C10, J11, H11	0	GV _{DD}	11
MCS[0:3]	K8, J8, G8, F8	0	GV _{DD}	—
MCK[0:5]	H9, B15, G2, M9, A14, F1	0	GV _{DD}	—
MCK[0:5]	J9, A15, G1, L9, B14, F2	0	GV _{DD}	—
MODT[0:3]	E6, K6, L7, M7	0	GV _{DD}	—
MDIC[0:1]	A19, B19	I/O	GV _{DD}	36

Signal	Package Pin Number	Pin Type	Power Supply	Notes			
Local Bus Controller Interface							
LAD[0:31]	E27, B20, H19, F25, A20, C19, E28, J23, A25, K22, B28, D27, D19, J22, K20, D28, D25, B25, E22, F22, F21, C25, C22, B23, F20, A23, A22, E19, A21, D21, F19, B21	I/O	BV _{DD}	_			
LDP[0:3]	K21, C28, B26, B22	I/O	BV _{DD}	—			
LA[27]	H21	0	BV _{DD}	5, 9			
LA[28:31]	H20, A27, D26, A28	0	BV _{DD}	5, 7, 9			
LCS[0:4]	J25, C20, J24, G26, A26	0	BV _{DD}	—			
LCS5/DMA_DREQ2	D23	I/O	BV _{DD}	1			
LCS6/DMA_DACK2	G20	0	BV _{DD}	1			
LCS7/DMA_DDONE2	E21	0	BV _{DD}	1			
LWE0/LBS0/LSDDQM[0]	G25	0	BV _{DD}	5, 9			
LWE1/LBS1/LSDDQM[1]	C23	0	BV _{DD}	5, 9			
LWE2/LBS2/LSDDQM[2]	J21	0	BV _{DD}	5, 9			
LWE3/LBS3/LSDDQM[3]	A24	0	BV _{DD}	5, 9			
LALE	H24	0	BV _{DD}	5, 8, 9			
LBCTL	G27	0	BV _{DD}	5, 8, 9			
LGPL0/LSDA10	F23	0	BV _{DD}	5, 9			
LGPL1/LSDWE	G22	0	BV _{DD}	5, 9			
LGPL2/LOE/LSDRAS	B27	0	BV _{DD}	5, 8, 9			
LGPL3/LSDCAS	F24	0	BV _{DD}	5, 9			
LGPL4/LGTA/LUPWAIT/LPBSE	H23	I/O	BV _{DD}	—			
LGPL5	E26	0	BV _{DD}	5, 9			
LCKE	E24	0	BV _{DD}	—			
LCLK[0:2]	E23, D24, H22	0	BV _{DD}	—			
LSYNC_IN	F27	I	BV _{DD}	—			
LSYNC_OUT	F28	0	BV _{DD}	—			
	DMA						
DMA_DACK[0:1]	AD3, AE1	0	OV _{DD}	5, 9, 107			
DMA_DREQ[0:1]	AD4, AE2	I	OV _{DD}	_			
DMA_DDONE[0:1]	AD2, AD1	0	OV _{DD}	_			
	Programmable Interrupt Controller						
UDE	AH16	I	OV _{DD}	_			
MCP	AG19		OV _{DD}	_			

Signal	Package Pin Number	Pin Type	Power Supply	Notes
MDIC[0:1]	A19, B19	I/O	GV _{DD}	36
	Local Bus Controller Interface			
LAD[0:31]	E27, B20, H19, F25, A20, C19, E28, J23, A25, K22, B28, D27, D19, J22, K20, D28, D25, B25, E22, F22, F21, C25, C22, B23, F20, A23, A22, E19, A21, D21, F19, B21	I/O	BV _{DD}	_
LDP[0:3]	K21, C28, B26, B22	I/O	BV _{DD}	—
LA[27]	H21	0	BV _{DD}	5, 9
LA[28:31]	H20, A27, D26, A28	0	BV _{DD}	5, 7, 9
LCS[0:4]	J25, C20, J24, G26, A26	0	BV _{DD}	_
LCS5/DMA_DREQ2	D23	I/O	BV _{DD}	1
LCS6/DMA_DACK2	G20	0	BV _{DD}	1
LCS7/DMA_DDONE2	E21	0	BV _{DD}	1
LWE0/LBS0/LSDDQM[0]	G25	0	BV _{DD}	5, 9
LWE1/LBS1/LSDDQM[1]	C23	0	BV _{DD}	5, 9
LWE2/LBS2/LSDDQM[2]	J21	0	BV _{DD}	5, 9
LWE3/LBS3/LSDDQM[3]	A24	0	BV _{DD}	5, 9
LALE	H24	0	BV _{DD}	5, 8, 9
LBCTL	G27	0	BV _{DD}	5, 8, 9
LGPL0/LSDA10	F23	0	BV _{DD}	5, 9
LGPL1/LSDWE	G22	0	BV _{DD}	5, 9
LGPL2/LOE/LSDRAS	B27	0	BV _{DD}	5, 8, 9
LGPL3/LSDCAS	F24	0	BV _{DD}	5, 9
LGPL4/LGTA/LUPWAIT/LPBSE	H23	I/O	BV _{DD}	_
LGPL5	E26	0	BV _{DD}	5, 9
LCKE	E24	0	BV _{DD}	_
LCLK[0:2]	E23, D24, H22	0	BV _{DD}	_
LSYNC_IN	F27	I	BV _{DD}	_
LSYNC_OUT	F28	0	BV _{DD}	_
	DMA			
DMA_DACK[0:1]	AD3, AE1	0	OV _{DD}	5, 9, 106
DMA_DREQ[0:1]	AD4, AE2	I	OV _{DD}	_
DMA_DDONE[0:1]	AD2, AD1	0	OV _{DD}	—
	Programmable Interrupt Controller		1	1

Clocking

	Maximum Processor Core Frequency					
Characteristic	800 MHz		1000 MHz		Unit	Notes
	Min	Max	Min	Max		
e500 core processor frequency	800	800	800	1000	MHz	1, 2

Table 77. Processor Core Clocking Specifications (MPC8543E)

Notes:

1. **Caution:** The CCB to SYSCLK ratio and e500 core to CCB ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB frequency do not exceed their respective maximum or minimum operating frequencies. See Section 20.2, "CCB/SYSCLK PLL Ratio," and Section 20.3, "e500 Core PLL Ratio," for ratio settings.

2.)The minimum e500 core frequency is based on the minimum platform frequency of 333 MHz.

Table 78. Memory Bus Clocking Specifications (MPC8548E and MPC8547E)

Characteristic	Maximum Processor Core Frequency 1000, 1200, 1333 MHz		Unit	Notes
	Min	Мах		
Memory bus clock speed	166	266	MHz	1, 2

Notes:

1. **Caution:** The CCB clock to SYSCLK ratio and e500 core to CCB clock ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB clock frequency do not exceed their respective maximum or minimum operating frequencies. See Section 20.2, "CCB/SYSCLK PLL Ratio," and Section 20.3, "e500 Core PLL Ratio," for ratio settings.

2. The memory bus speed is half of the DDR/DDR2 data rate, hence, half of the platform clock frequency.

Table 79. Memory Bus Clocking Specifications (MPC8545E)

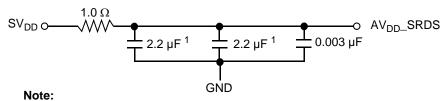
Characteristic	Maximum Processor Core Frequency 800, 1000, 1200 MHz		Unit	Notes
	Min	Мах]	
Memory bus clock speed	166	200	MHz	1, 2

Notes:

 Caution: The CCB clock to SYSCLK ratio and e500 core to CCB clock ratio settings must be chosen such that the resulting SYSCLK frequency, e500 (core) frequency, and CCB clock frequency do not exceed their respective maximum or minimum operating frequencies. See Section 20.2, "CCB/SYSCLK PLL Ratio," and Section 20.3, "e500 Core PLL Ratio," for ratio settings.

2. The memory bus speed is half of the DDR/DDR2 data rate, hence, half of the platform clock frequency.

the ground plane. Use ceramic chip capacitors with the highest possible self-resonant frequency. All traces must be kept short, wide and direct.



1. An 0805 sized capacitor is recommended for system initial bring-up.

Figure 60. SerDes PLL Power Supply Filter

Note the following:

- AV_{DD}_SRDS must be a filtered version of SV_{DD}.
- Signals on the SerDes interface are fed from the XV_{DD} power plane.

22.3 Decoupling Recommendations

Due to large address and data buses, and high operating frequencies, the device can generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the device system, and the device itself requires a clean, tightly regulated source of power. Therefore, it is recommended that the system designer place at least one decoupling capacitor at each V_{DD} , TV_{DD} , BV_{DD} , OV_{DD} , GV_{DD} , and LV_{DD} pin of the device. These decoupling capacitors must receive their power from separate V_{DD} , TV_{DD} , BV_{DD} , OV_{DD} , GV_{DD} , DV_{DD} , DV_{DD} , DV_{DD} , OV_{DD} , GV_{DD} , DV_{DD} , DV_{DD} , OV_{DD} , GV_{DD} , DV_{DD} , DV_{DD} , DV_{DD} , DV_{DD} , OV_{DD} , GV_{DD} , DV_{DD} , DV

These capacitors must have a value of 0.1 μ F. Only ceramic SMT (surface mount technology) capacitors must be used to minimize lead inductance, preferably 0402 or 0603 sizes. Besides, it is recommended that there be several bulk storage capacitors distributed around the PCB, feeding the V_{DD}, TV_{DD}, BV_{DD}, OV_{DD}, GV_{DD}, and LV_{DD}, planes, to enable quick recharging of the smaller chip capacitors. These bulk capacitors must have a low ESR (equivalent series resistance) rating to ensure the quick response time necessary. They must also be connected to the power and ground planes through two vias to minimize inductance. Suggested bulk capacitors—100–330 μ F (AVX TPS tantalum or Sanyo OSCON). However, customers must work directly with their power regulator vendor for best values, types and quantity of bulk capacitors.

22.4 SerDes Block Power Supply Decoupling Recommendations

The SerDes block requires a clean, tightly regulated source of power (SV_{DD} and XV_{DD}) to ensure low jitter on transmit and reliable recovery of data in the receiver. An appropriate decoupling scheme is outlined below.

Only surface mount technology (SMT) capacitors must be used to minimize inductance. Connections from all capacitors to power and ground must be done with multiple vias to further reduce inductance.